Application/Control No. Applicant(s)/Patent Under Reexamination 10/562,182 PAN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2821 HoangAnh T. Le **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY * 343/702 US-6,744,410 06-2004 Shamblin et al. Α 343/702 US-2003/0122718 07-2003 Fang et al. В 343/702 С US-2003/0201942 10-2003 Poilasne et al. US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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